

SPECIFICATION

DEVICE NAME : Power MOSFET

TYPE NAME : 2SK2832-01

SPEC. No. :

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Fuji Electric Co., Ltd.
Matsumoto Factory

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	DATE	NAME	APPROVED	Fuji Electric Co., Ltd.	
DRAWN				DWG. NO.	1/11
CHECKED					

1. Scope
This specifies Fuji power MOSFET 2SK2832-01
2. Construction N-channel enhancement mode power MOSFET
3. Application for switching
4. Outview T0-220 Outview See to 5/11 page
5. Absolute maximum ratings at $T_c=25^\circ\text{C}$ (unless otherwise specified)

Description	Symbol	Characteristics	Unit	
Drain-source voltage	V_{DS}	60	V	
Drain-gate voltage	V_{DGR}	60	V	$R_{GS}=20\text{ k}\Omega$
Continuous Drain current	I_D	± 50	A	
Pulsed drain current	I_{DPulse}	± 200	A	
Gate-source voltage	V_{GS}	± 20	V	
Maximum power dissipation	P_D	80	W	
Operating and storage temperature range	T_{ch}	150	$^\circ\text{C}$	
	$T_{stg.}$	-55 ~ +150	$^\circ\text{C}$	

6. Electrical characteristics at $T_c=25^\circ\text{C}$ (unless otherwise specified)
Static ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Drain-source breakdown voltage	$B V_{DSS}$	$I_D = 1\text{mA}$ $V_{GS} = 0\text{V}$	60			V
Gate threshold voltage	$V_{GS(th)}$	$I_D = 1\text{mA}$ $V_{DS} = V_{GS}$	1.0	1.5	2.0	V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 60\text{V}$ $V_{GS} = 0\text{V}$	$T_{ch} = 25^\circ\text{C}$	10	500	μA
	I_{DSS}		$T_{ch} = 125^\circ\text{C}$	0.2	1.0	mA
Gate-source leakage current	I_{GSS}	$V_{GS} = \pm 20\text{V}$ $V_{DS} = 0\text{V}$		10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 25\text{A}$	$V_{GS} = 4\text{V}$	22	34	m Ω
			$V_{GS} = 10\text{V}$	14	20	

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Dynamic ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Forward transconductance	g_{fs}	$I_D = 25A$ $V_{DS} = 25V$	17	35		S
Input capacitance	C_{iss}	$V_{DS} = 25V$ $V_{GS} = 0V$ $f = 1MHz$		3100	4650	pF
Output capacitance	C_{oss}			920	1380	pF
Reverse transfer capacitance	C_{rss}			370	560	pF
Turn-on time	$t_{d(on)}$	$V_{CC} = 30V$ $V_{GS} = 10V$ $I_D = 50A$ $R_{GS} = 10\Omega$		15	30	ns
	t_r			40	60	ns
Turn-off time	$t_{d(off)}$			180	270	ns
	t_f			100	150	ns

Reverse diode

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Avalanche capability	I_{AV}	$L = 100\mu H, T_{ch} = 25^\circ C$ *See Fig.1 and 2	50.0			A
Diode forward on-voltage	V_{SD}	$I_F = 2 \times I_{DR}$ $V_{GS} = 0V, T_{ch} = 25^\circ C$		1.3	1.9	V
Reverse recovery time	t_{rr}	$I_F = I_{DR}$ $V_{GS} = 0V$ $-di_F/dt = 100A/\mu s$ $T_{ch} = 25^\circ C$		70		ns
Reverse recovery charge	Q_{rr}				110	

7. Thermal resistance

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Thermal resistance	$R_{th_{ch-c}}$				1.56	$^\circ C/W$
	$R_{th_{ch-a}}$				125	$^\circ C/W$

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Fig.1 Test circuit

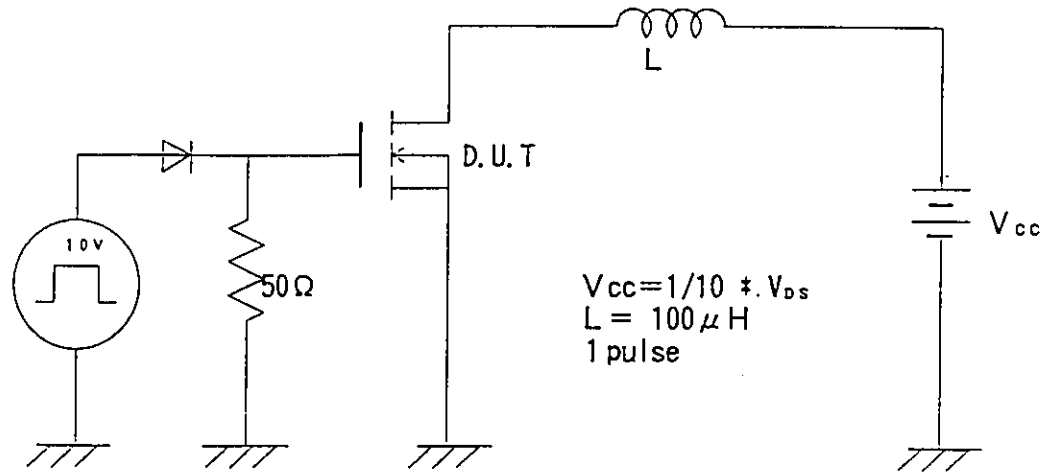
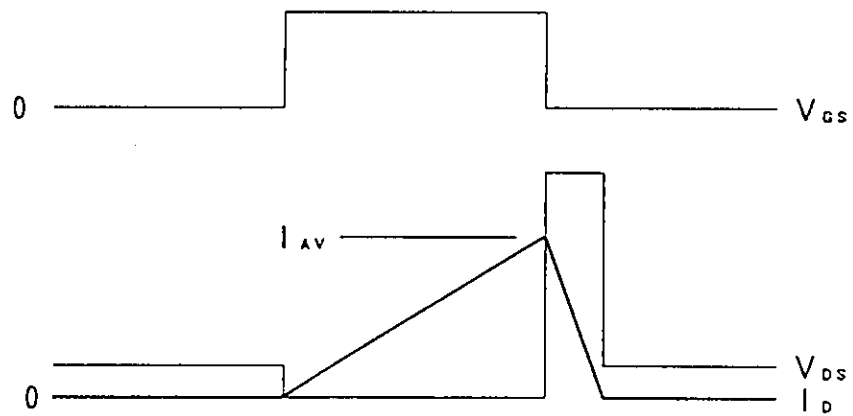
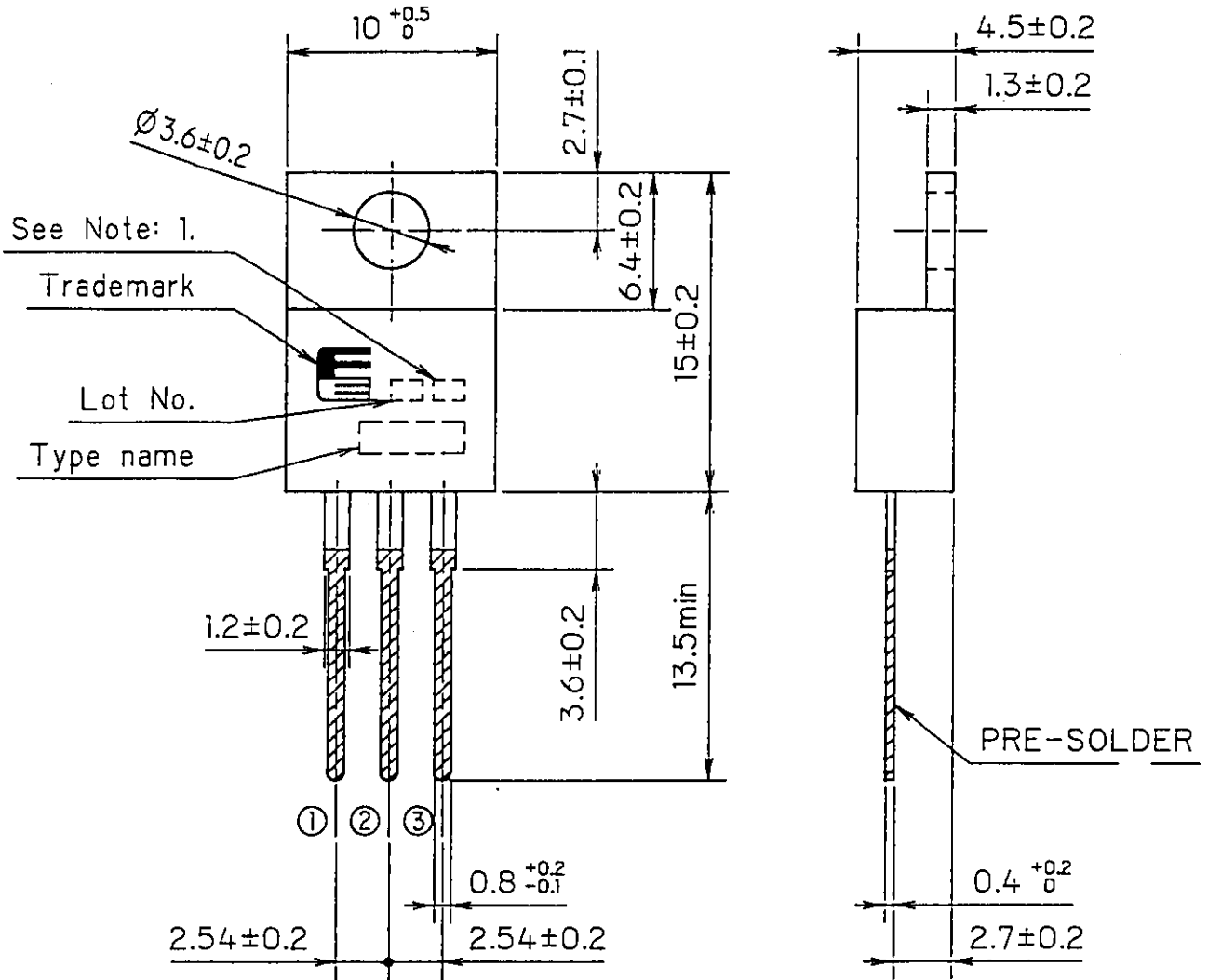


Fig.2 Operating waveforms



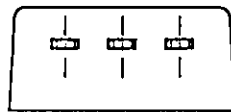
FUJI POWER MOS FET

TYPE :



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CONNECTION



① ② ③

- ① GATE
- ② DRAIN
- ③ SOURCE

Note: 1. $V_{GS(th)}$ selected code.

JEDEC : TO-220AB

Note: 1. Guaranteed mark of avalanche ruggedness.

DIMENSIONS ARE IN MILLIMETERS.

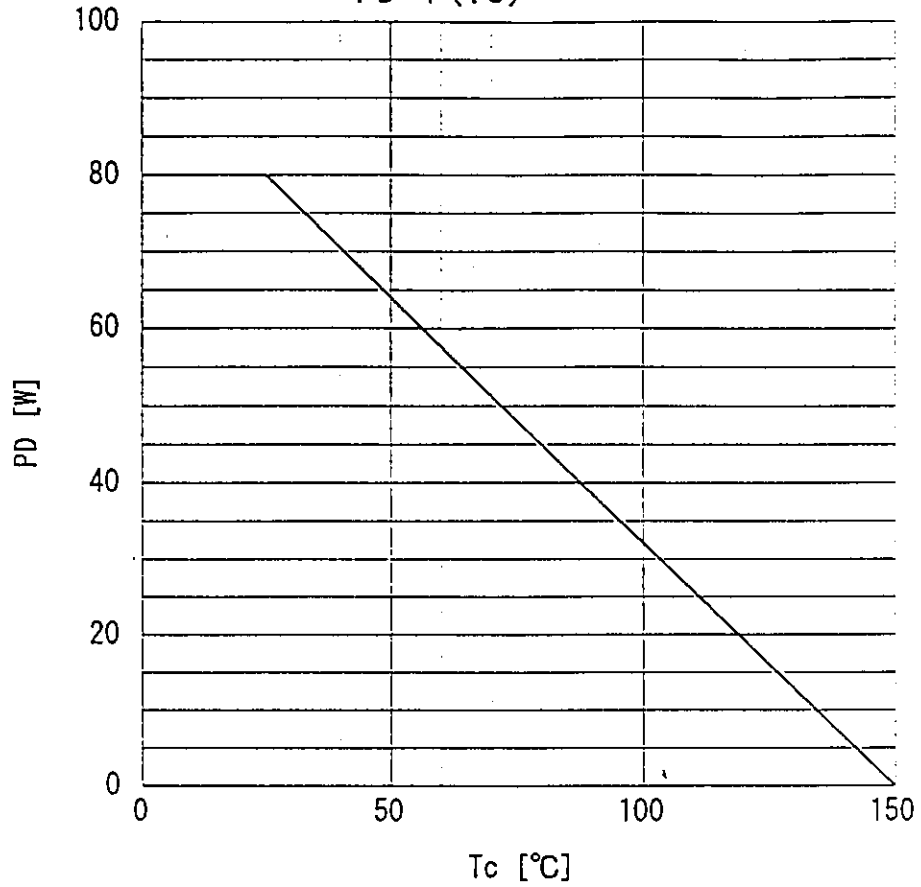
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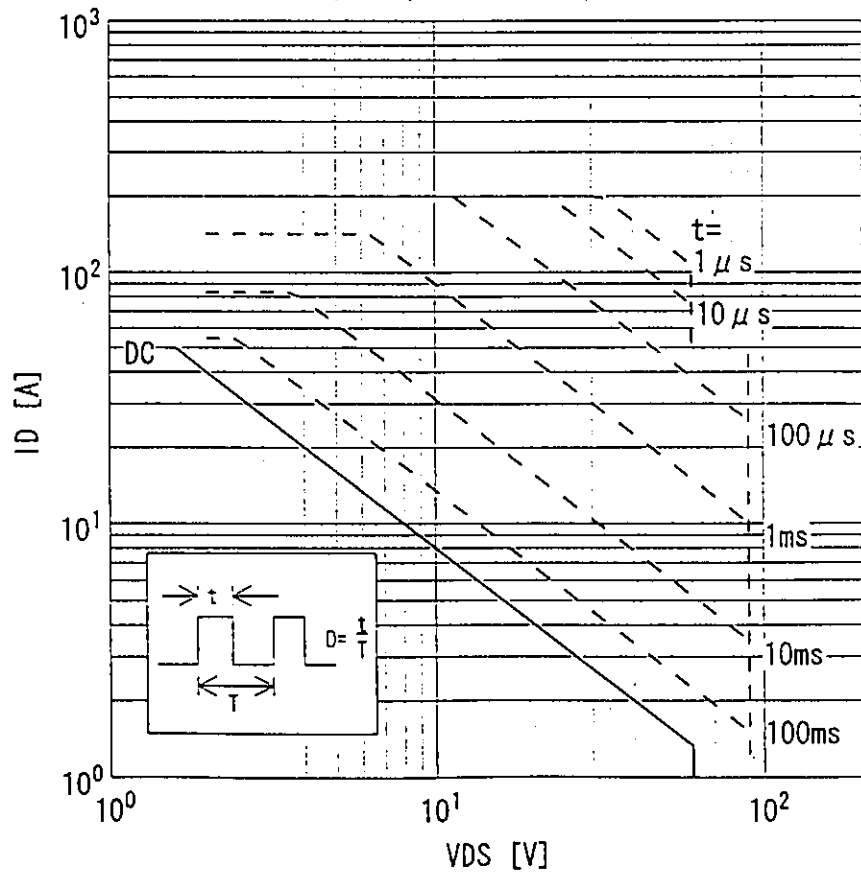
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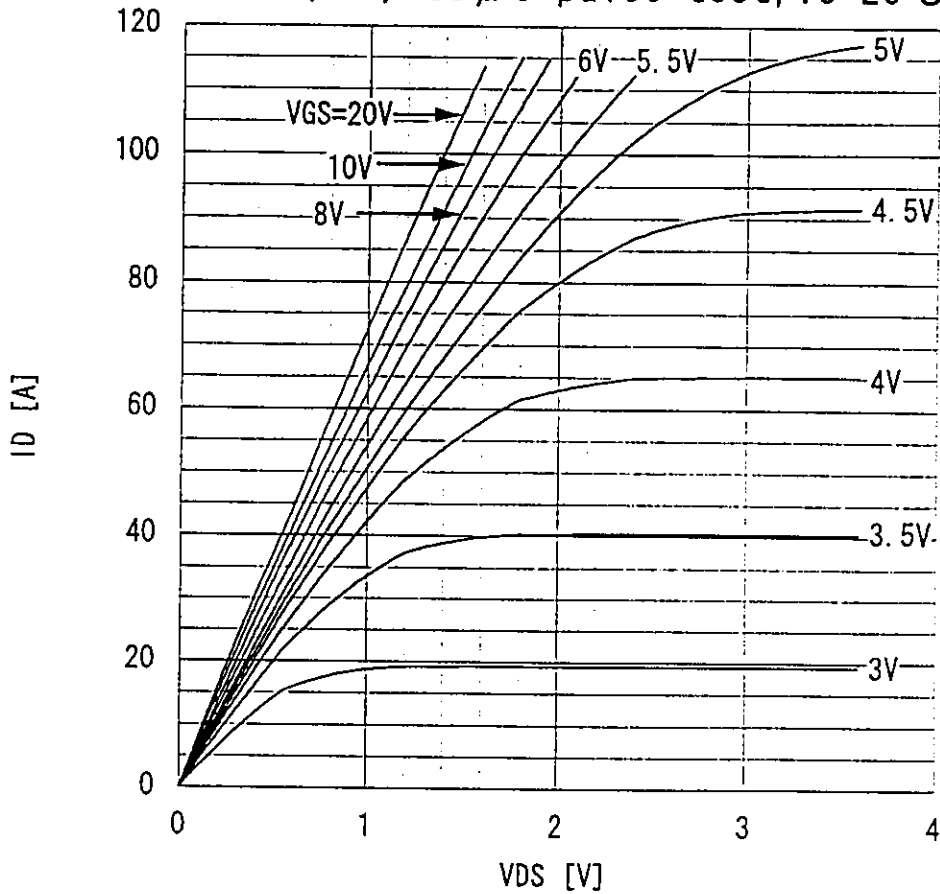
Power Dissipation
 $PD=f(T_c)$



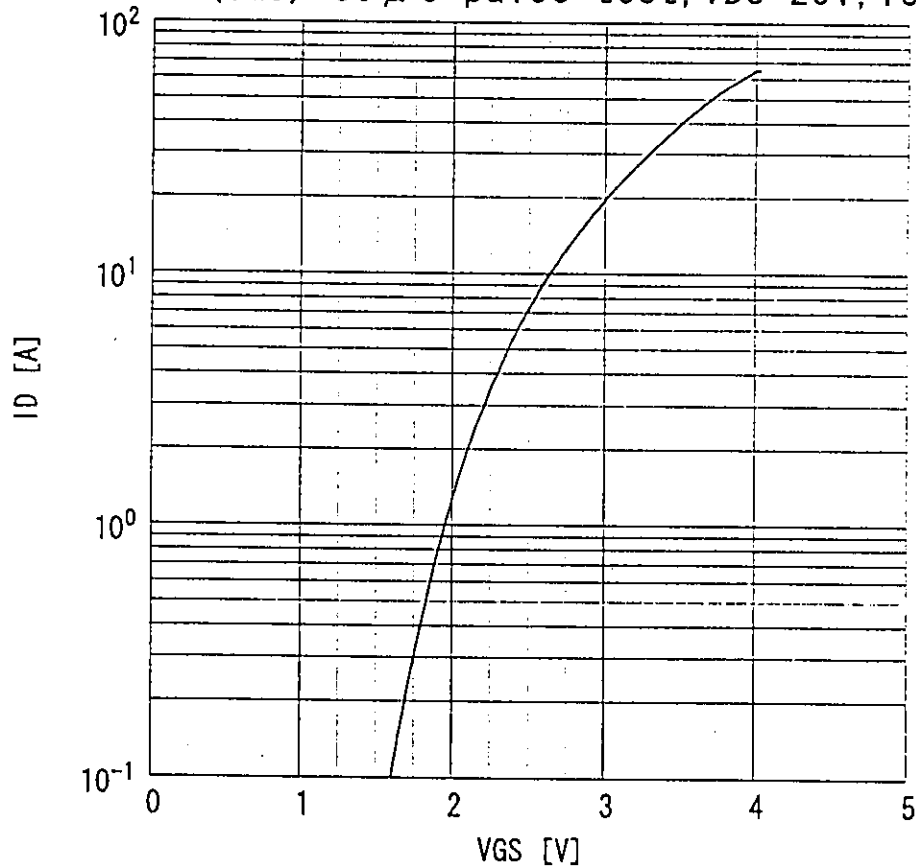
Safe operating area
 $ID=f(V_{DS}) : D=0.01, T_c=25^\circ\text{C}$



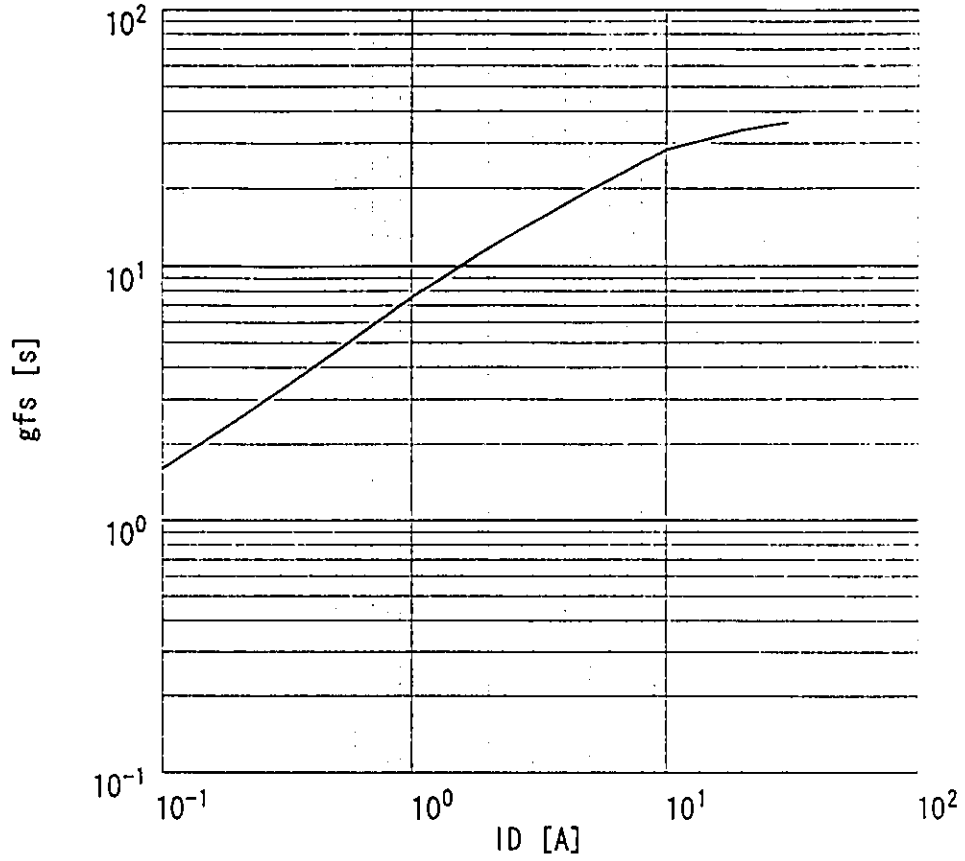
Typical output characteristics
 $I_D = f(V_{DS}) : 80 \mu s$ pulse test, $T_c = 25^\circ C$



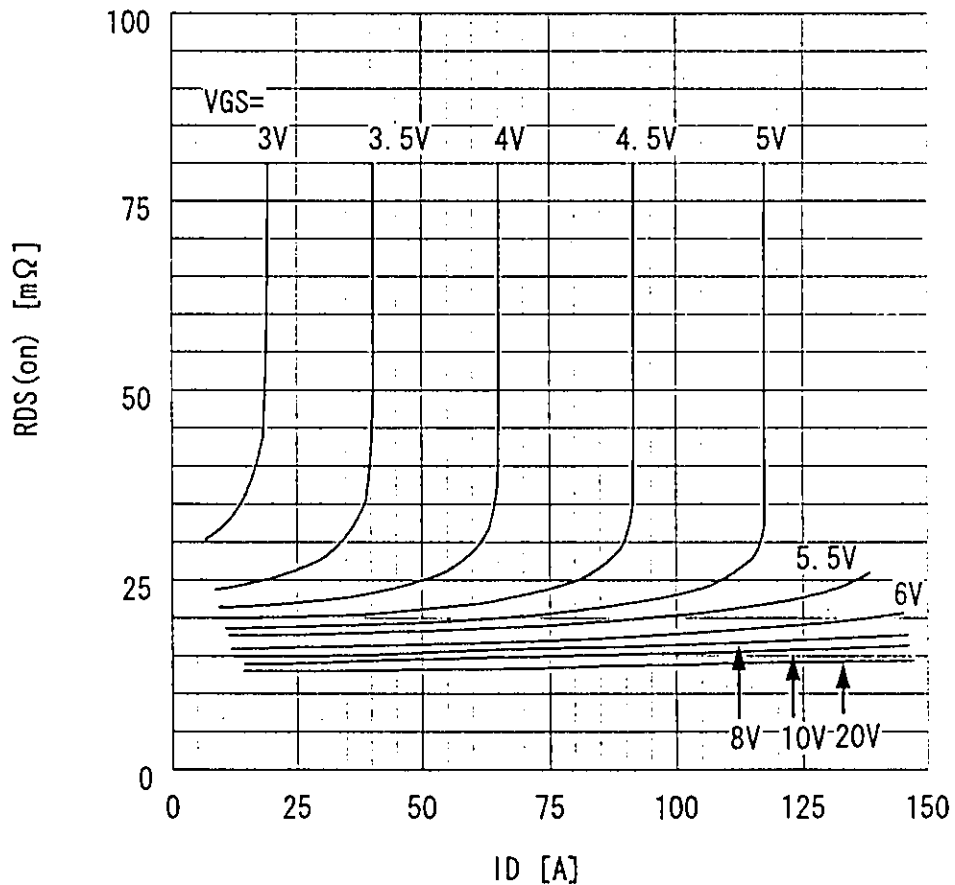
Typical transfer characteristic
 $I_D = f(V_{GS}) : 80 \mu s$ pulse test, $V_{DS} = 25V$, $T_{ch} = 25^\circ C$



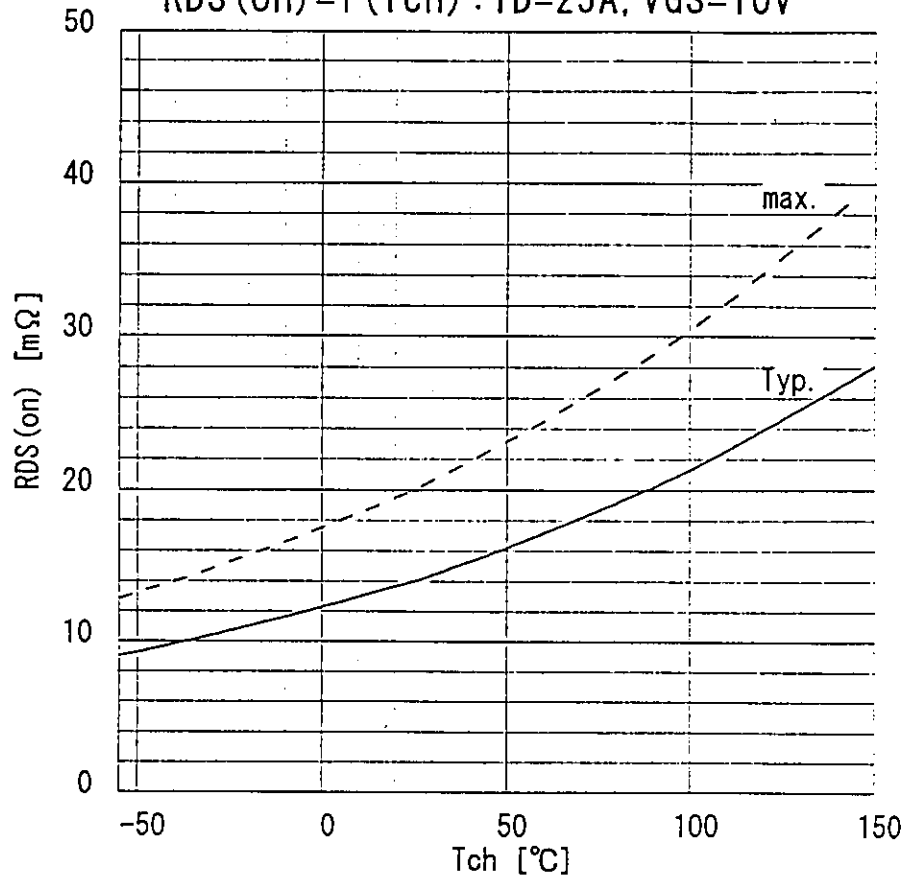
Typical forward transconductance
 $g_{fs} = f(I_D)$: 80 μ s pulse test, $V_{DS} = 25V$, $T_{ch} = 25^\circ C$



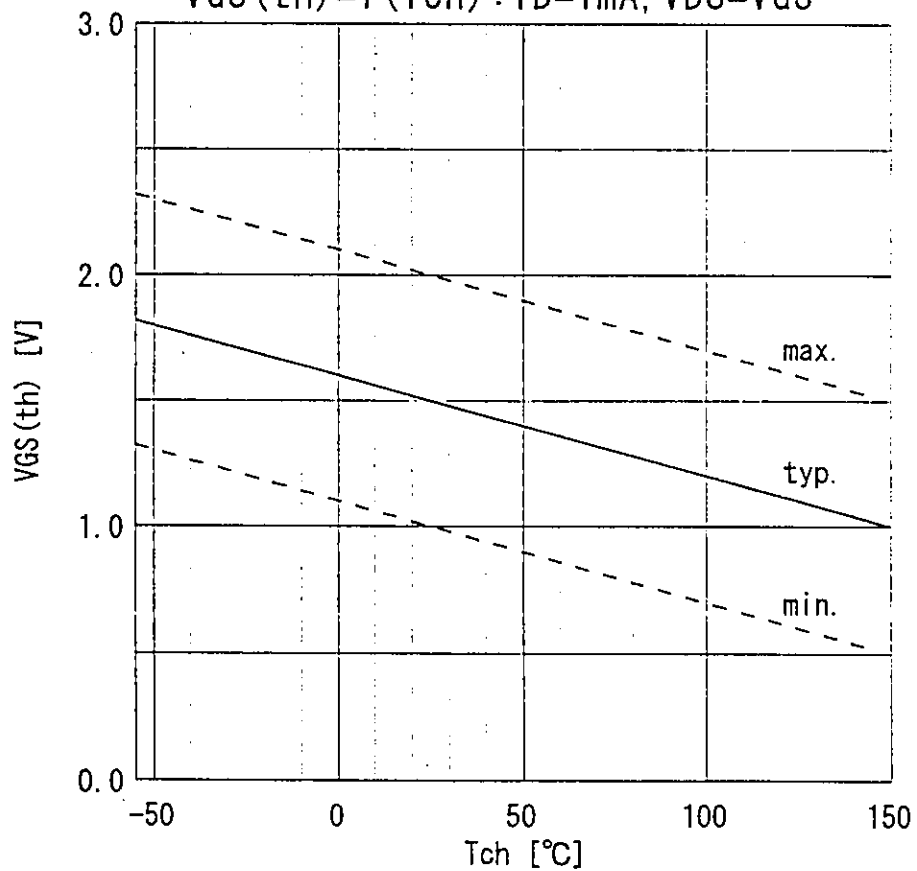
Typical drain-source on-state resistance
 $R_{DS(on)} = f(I_D)$: 80 μ s pulse test, $T_c = 25^\circ C$



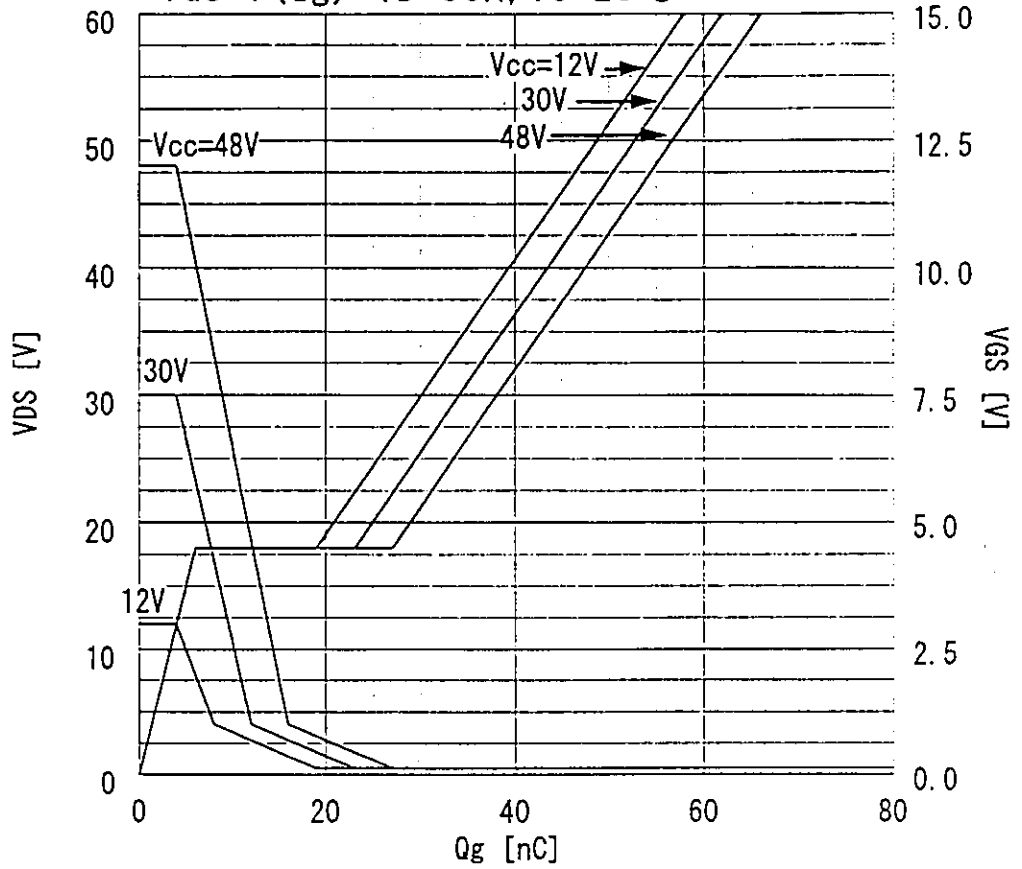
Drain-source on-state resistance
 $R_{DS(on)} = f(T_{ch}) : I_D = 25A, V_{GS} = 10V$



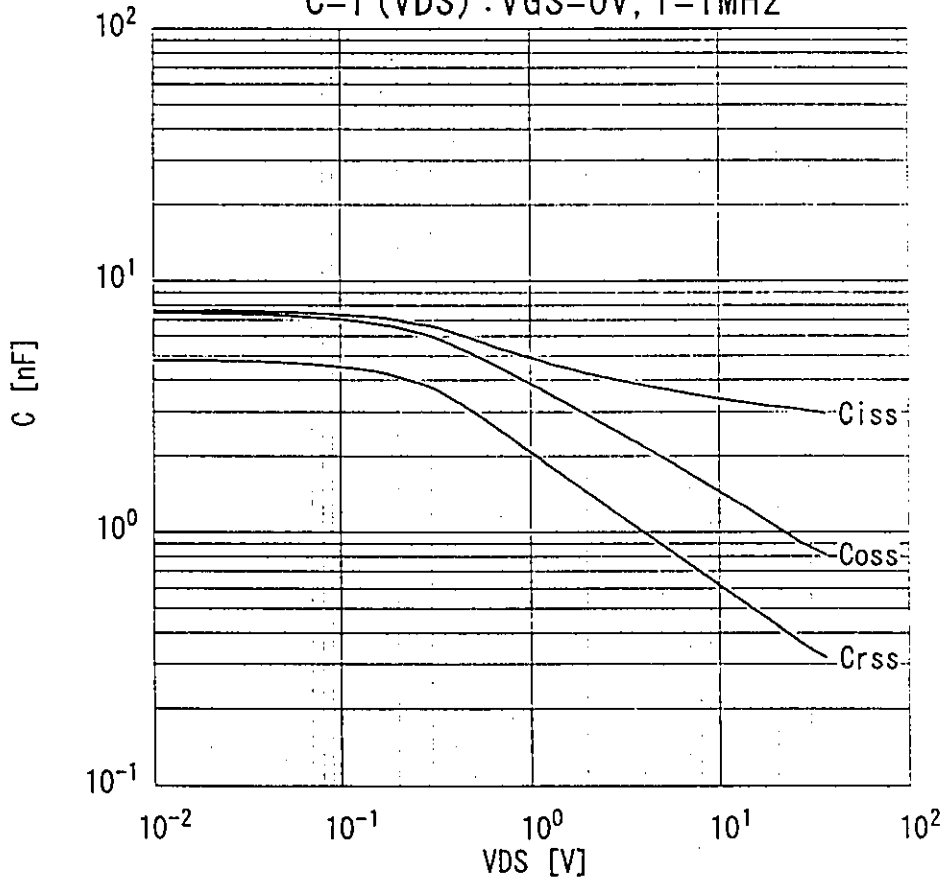
Gate threshold voltage
 $V_{GS(th)} = f(T_{ch}) : I_D = 1mA, V_{DS} = V_{GS}$



Typical gate charge characteristic
 $V_{GS} = f(Q_g) : I_D = 50A, T_c = 25^\circ C$

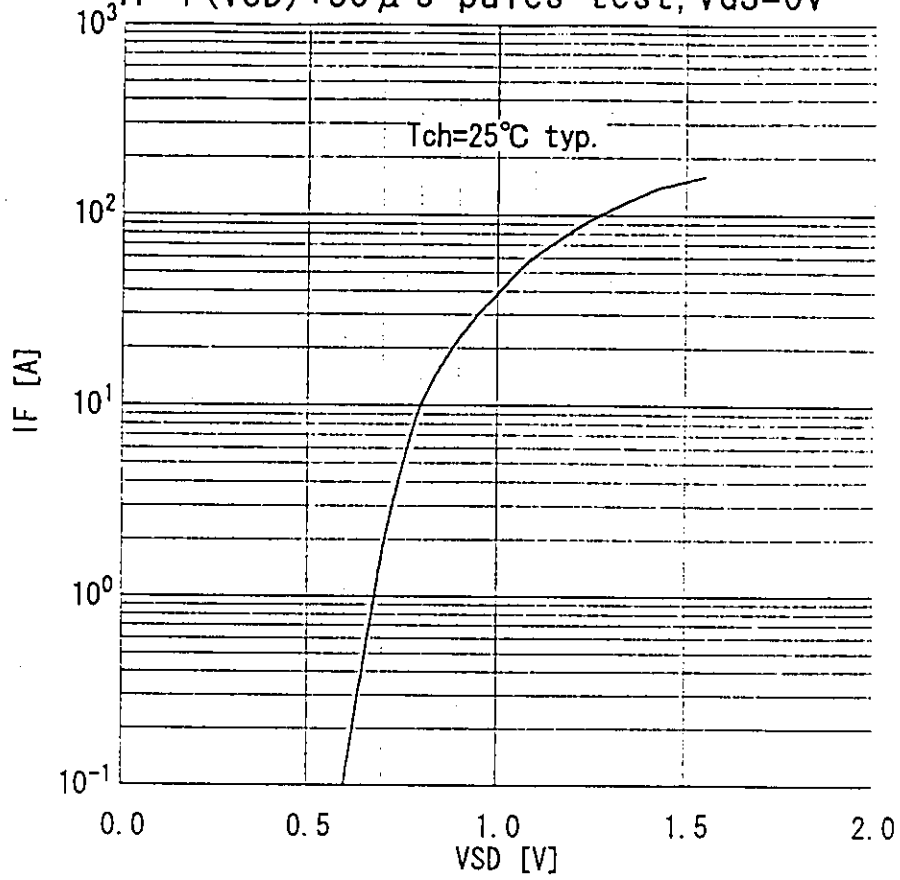


Typical capacitances
 $C = f(V_{DS}) : V_{GS} = 0V, f = 1MHz$



Forward characteristic of reverse diode

$I_F = f(V_{SD}) : 80 \mu s$ pulses test, $V_{GS} = 0V$



Transient thermal impedance

$Z_{thch} = f(t)$ parameter: $D = t/T$

